

Notice of References Cited

Application/Control No.

10/500,486

Applicant(s)/Patent Under
Reexamination
IRIKUCHI ET AL.

Examiner

DANIEL TEKLE

Art Unit

2621

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0092021	07-2002	Yap et al.	725/55
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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